

# SEARCHED

Class	Sub.	Date	Exmr.
250	310	12-11-00	K.F.
250	310	4-12-01	KK
	307		
	492.2		
250	310	7-31-01	LF
	308		
	311		
	492.2		
250	492.2	2-23-04	KF
	492.1		

# SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	Date	Exmr.
electron scanning microscope	12-14-00	K.F.
interferometer	12-14-00	K.F.
East	4-12-01	K.F.
East	7-31-01	K.F.
East	2-23-04	K.F.

# INTERFERENCE SEARCHED

Class	Sub.	Date	Exmr.

Best Available Copy